

**Search Notes**

Application/Control No.

09/809,332

Examiner

DANG T. TON

Applicant(s)/Patent under  
Reexamination

HEIN ET AL.

Art Unit

2666

**SEARCHED**

Class	Subclass	Date	Examiner
<i>updated</i>		<i>3/13/06</i>	<i>FD</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
<i>370</i>	<i>240</i>	<i>3/13/06</i>	<i>FD</i>

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
<i>Interference searched</i>	<i>3/13/06</i>	<i>FD</i>